MN39217FH

Diagonal 4.5 mm (type-1/4) 320k-pixel CCD Area Image Sensor

Overview

The MN39217FH is a 4.5 mm (type-1/4) interline transfer CCD (IT-CCD) solid state image sensor device.

This device uses photodiodes in the optoelectric conversion section and CCDs for signal readout. The electronic shutter function has made an exposure time of 1/10000 seconds possible. Further, this device has the features of high sensitivity, low noise, broad dynamic range, and low smear.

This device has a total of 320589 pixels (537 horizontal \times 597 vertical) and provides stable and clear images with a resolution of 330 horizontal TV-lines and 420 vertical TV-lines.

Part Number Size		System	Color or B/W		
MN39217FH	4.5 mm (type-1/4)	PAL	Color		

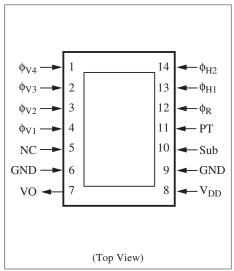
Features

- Effective pixel number 500 (horizontal) × 582 (vertical)
- High sensitivity
- Broad dynamic range
- Low smear
- Electronic shutter

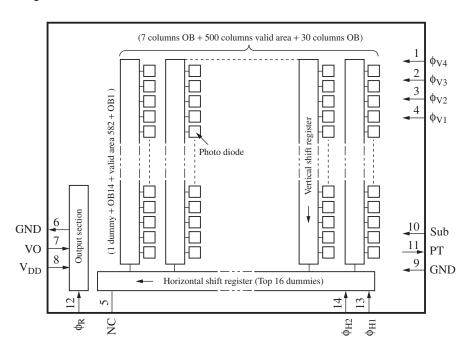
Applications

Camcorders

■ Pin Assignments



■ Block Diagram



■ Pin Descriptions

Pin No.	Symbol	Description	Pin No.	Symbol	Description
1	φ _{V4}	Vertical shift register clock pulse 4	8	V _{DD}	Power supply
2	φ _{V3}	Vertical shift register clock pulse 3	9	GND	GND
3	φ _{V2}	Vertical shift register clock pulse 2	10	Sub	Substrate
4	φ _{V1}	Vertical shift register clock pulse 1	11	PT	P-well for protection circuit
5	NC	NC	12	ϕ_{R}	Reset pulse (RG)
6	GND	GND	13	ф _{Н1}	Horizontal register clock pulse 1
7	VO	Video output	14	ф _{H2}	Horizontal register clock pulse 2

■ Device Parameter (H × V)

Parameter	Value	Unit
Pixel number *	500 × 582	pixel
Image sensing block dimension	3.599×2.698	mm ²
Pixel dimension	7.30×4.70	μm ²

Note) *: OB columns are not included.

■ Absolute Maximum Ratings and Operating Conditions

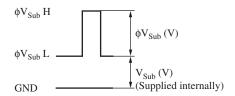
Parameter		Absolute maximum rating		Operating condition			
		Lower limit	Upper limit	Min	Тур	Max	Unit
V_{DD}		- 0.2	18.0	14.5	15.0	15.5	V
V _{PT} *3, 4		-10.0	0.2	-8.3	-8.0	-7.7	V
GND		(Reference	e voltage)	_	0	_	V
$V_{\phi R}$	High-Low	_	8.0	3.0	3.3	3.6	V
	Bias	(Supplied internally)					V
$V_{\phi H1}$	High	_	8.0	3.0	3.3	3.6	V
	Low	- 0.2	_	- 0.05	0	0.05	V
$V_{\phi H2}$	High	_	8.0	3.0	3.3	3.6	V
	Low	- 0.2	_	- 0.05	0	0.05	V
V _{Sub} *2			(S	upplied internal	V		
φV _{Sub} *1			45.0	22.0	23.0	24.0	V
$V_{\phi V1}^{*3, 4}$	High	_	18.0	14.5	15.0	15.5	V
	Middle	_	_	- 0.2	0	0.2	V
	Low	-9.0	_	-8.3	-8.0	-7.7	V
V _{\phiV2} *3, 4	Middle	_	15.0	- 0.2	0	0.2	V
	Low	-9.0	_	-8.3	-8.0	-7.7	V
V _{\phiV3} *3, 4	High	_	18.0	14.5	15.0	15.5	V
	Middle	_	_	- 0.2	0	0.2	V
	Low	-9.0	_	-8.3	-8.0	-7.7	V
$V_{\phi V4}$ *3, 4	Middle	_	15.0	- 0.2	0	0.2	V
	Low	-9.0	_	-8.3	-8.0	-7.7	V
Operating ter	mperature	-10	60	_	25	_	°C
Storage temp	perature	-30	80	_			°C

■ Absolute Maximum Ratings and Operating Conditions (continued)

Note) 1. Standard photo detecting condition

Standard photo detecting condition stands for detecting image with a light source of color temperature of 2856K, luminance of 1050 cd/m², and using a color temperature conversion filter LB-40 (HOYA), infrared cut filter CAW-500S with thickness 2.5 mm for a light path and with F8 lens aperture. The quantity of the incidental light to a photo-detecting surface under the above condition is defined as the standard quantity of light.

2. $*1: V_{Sub}$ when using electronic shutter function



* \$\phi Sub pulse generates once every 1 V period.

- *2: V_{Sub} supplied internally is the voltage suppressing the blooming generation at $\times 1000$ light quantity relative to the standard light quantity.
- *3: Relation between V_{PT} and $V_{\phi VL}$

Set V_{PT} under the following condition against VL of a vertical transfer clock waveform.

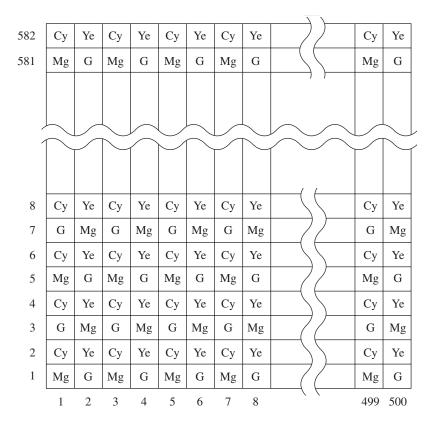
$$V_{PT} \le VL \ (V_{\phi V1L} \ to \ V_{\phi V4L})$$

*4: Absolute maximum ratings $-0.2 < V_{Sub} - V_{PT} < 55 \text{ (V)}$ $-0.2 < V_{\phi V} - V_{PT} < 24.5 \text{ (V)}$

■ Optical Characteristics

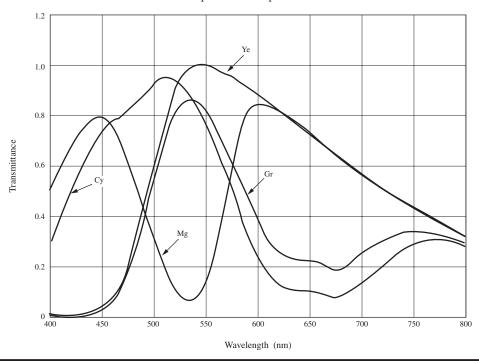
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
S/N ratio (dark)	S/Nd	Dark condition	57	60	_	dB
Sensitivity	So	J chart F8	340	380	_	mV
	So	J chart F1.4	220	250	_	mV
Carrier saturation output	Sc	Carrier maximum output	550	600	_	mV
Vertical smear	Sm	1/10 V chart, F1.4	_	_	0.01	%

■ Color Filter Arrays on CCD

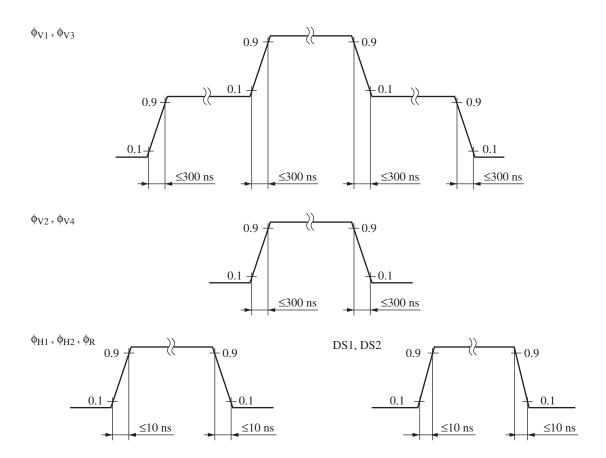


■ Graph of Characteristics

CCD on-chip color filter spectral characteristics

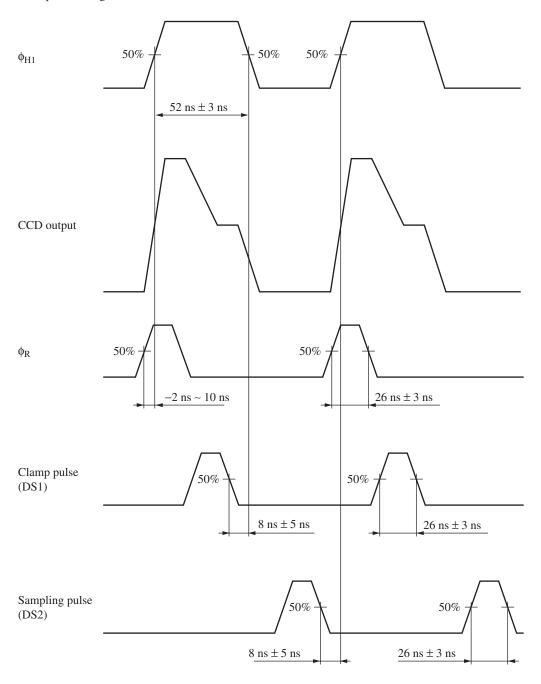


■ Timing Diagram



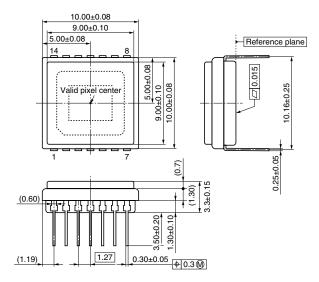
■ Timing Diagram (continued)

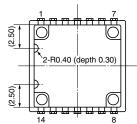
• CMOS pulse timing



■ Package Dimensions (unit: mm)

• WDIP014-P-0400H





- 1. The center of the package is equal to the center of the effective pixel area.
- 2. The rotation angle of the effective pixel area: up to ± 1.0 degree
- 3. The distance from the bottom face of the package to the surface of the effective pixel area: 1.41 mm \pm 0.1 mm
- 4. The tilt of the effective pixel area for the bottom face of the package: up to 25 μm
- 5. Thickness of seal glass is 0.7 mm \pm 0.1 mm, and the refractive index is 1.50.
- 6. Package weight: 0.55 g (typ.)

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